

Dual Enhancement Mode MOSFET (N- and P-Channel)

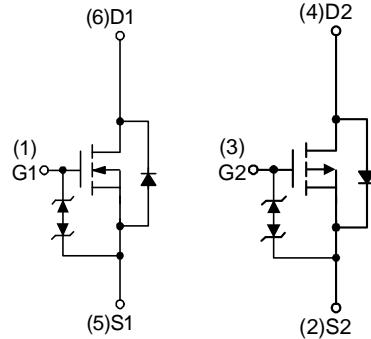
Features

- N-Channel
20V/3A,
 $R_{DS(ON)}=50m\Omega$ (typ.) @ $V_{GS}=4.5V$
 $R_{DS(ON)}=65m\Omega$ (typ.) @ $V_{GS}=2.5V$
- P-Channel
-20V/-2A,
 $R_{DS(ON)}=90m\Omega$ (typ.) @ $V_{GS}=-4.5V$
 $R_{DS(ON)}=130m\Omega$ (typ.) @ $V_{GS}=-2.5V$
- Reliable and Rugged
- Lead Free and Green Devices Available
(RoHS Compliant)

Pin Description



Top View of SOT-23-6

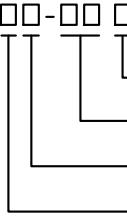
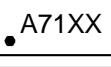


N-Channel MOSFET P-Channel MOSFET

Applications

- Power Management in Notebook Computer,
Portable Equipment and Battery Powered
Systems

Ordering and Marking Information

APM2701A 	Package Code C : SOT-23-6 Operating Junction Temperature Range C : -55 to 150 °C Handling Code TR : Tape & Reel (3000ea/reel) Assembly Material G : Halogen and Lead Free Device
APM2701A C : 	XX - Lot Code

Note : SINOPOWER lead-free products contain molding compounds/die attach materials and 100% matte tin plate termination finish; which are fully compliant with RoHS. SINOPOWER lead-free products meet or exceed the lead-free requirements of IPC/JEDEC J-STD-020D for MSL classification at lead-free peak reflow temperature. SINOPOWER defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

SINOPOWER reserves the right to make changes to improve reliability or manufacturability without notice, and advise customers to obtain the latest version of relevant information to verify before placing orders.

Absolute Maximum Ratings ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Rating		Unit
		N-Channel	P-Channel	
V_{DSS}	Drain-Source Voltage	20	-20	V
V_{GSS}	Gate-Source Voltage	± 12	± 12	
I_D^*	Continuous Drain Current	$V_{GS} = \pm 4.5\text{V}$	3	A
I_{DM}^*	300μs Pulsed Drain Current		12	
I_S^*	Diode Continuous Forward Current	1	-1	A
T_J	Maximum Junction Temperature	150		°C
T_{STG}	Storage Temperature Range	-55 to 150		
P_D^*	Power Dissipation	$T_A = 25^\circ\text{C}$	0.83	W
		$T_A = 100^\circ\text{C}$	0.3	
$R_{\theta JA}^*$	Thermal Resistance-Junction to Ambient	150		°C/W

Note : *Surface Mounted on 1in²pad area, t ≤ 10sec.

Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
Static Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_{DS}=250\mu\text{A}$	N-Ch	20	-	-
		$V_{GS}=0\text{V}, I_{DS}=-250\mu\text{A}$	P-Ch	-20	-	-
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=16\text{V}, V_{GS}=0\text{V}$ $T_J=85^\circ\text{C}$	N-Ch	-	-	1
				-	-	30
		$V_{DS}=-16\text{V}, V_{GS}=0\text{V}$ $T_J=85^\circ\text{C}$	P-Ch	-	-	-1
				-	-	-30
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_{DS}=250\mu\text{A}$	N-Ch	0.5	0.7	1
		$V_{DS}=V_{GS}, I_{DS}=-250\mu\text{A}$	P-Ch	-0.5	-0.7	-1
I_{GSS}	Gate Leakage Current	$V_{GS}=\pm 10\text{V}, V_{DS}=0\text{V}$	N-Ch	-	-	± 10
			P-Ch	-	-	± 10
$R_{DS(ON)}^a$	Drain-Source On-State Resistance	$V_{GS}=4.5\text{V}, I_{DS}=3\text{A}$	N-Ch	-	50	65
		$V_{GS}=-4.5\text{V}, I_{DS}=-2\text{A}$	P-Ch	-	90	120
		$V_{GS}=2.5\text{V}, I_{DS}=1.7\text{A}$	N-Ch	-	65	90
		$V_{GS}=-2.5\text{V}, I_{DS}=-1\text{A}$	P-Ch	-	130	180

Electrical Characteristics (Cont.) ($T_A = 25^\circ\text{C}$ unless otherwise noted)

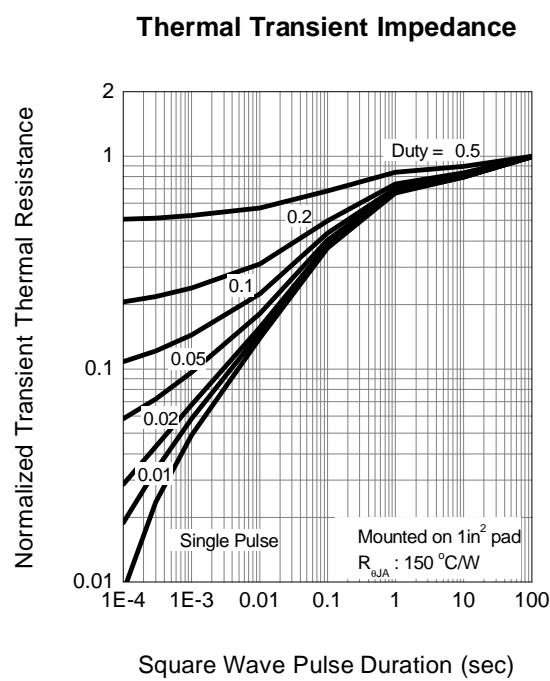
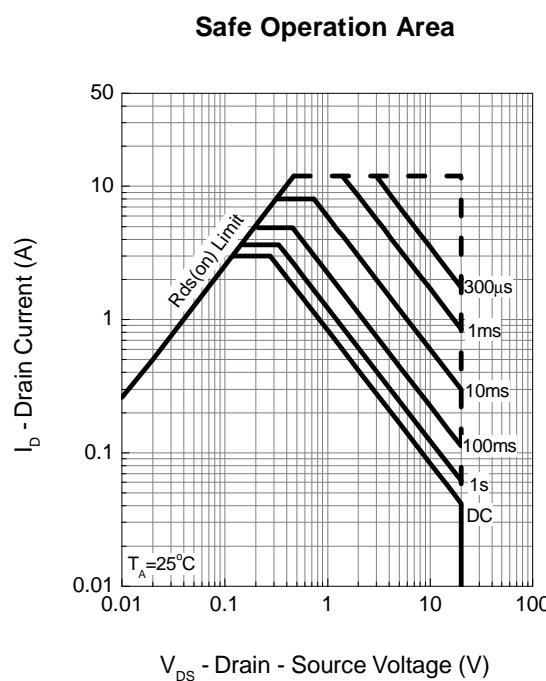
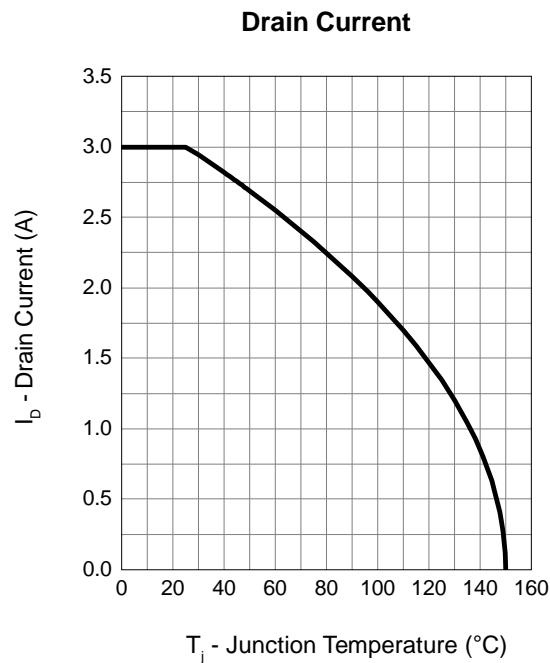
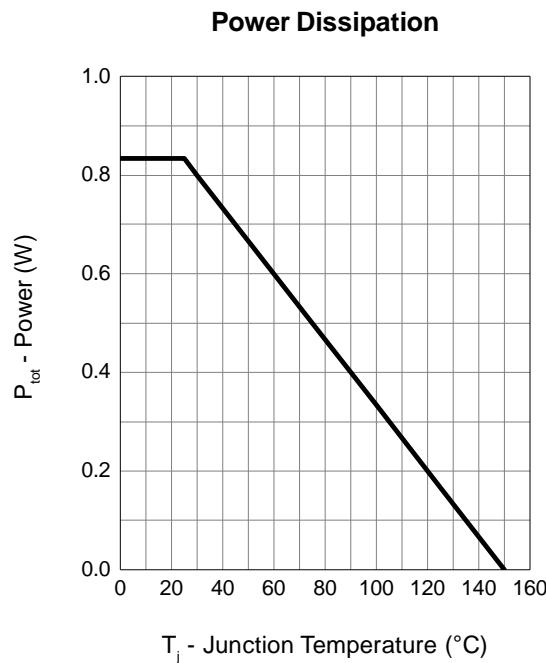
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
Diode Characteristics						
V_{SD}^a	Diode Forward Voltage	$I_{SD}=0.5\text{A}, V_{GS}=0\text{V}$	N-Ch	-	0.7	1.3
		$I_{SD}=-0.5\text{A}, V_{GS}=0\text{V}$	P-Ch	-	-0.7	-1.3
t_{rr}	Reverse Recovery Time	N-Channel $I_{SD}=3\text{A},$ $dI_{SD}/dt=100\text{A}/\mu\text{s}$	N-Ch	-	11	-
			P-Ch	-	12	-
Q_{rr}	Reverse Recovery Charge	P-Channel $I_{SD}=-2\text{A},$ $dI_{SD}/dt=100\text{A}/\mu\text{s}$	N-Ch	-	4	-
			P-Ch	-	4	-
Dynamic Characteristics^b						
C_{iss}	Input Capacitance	N-Channel $V_{GS}=0\text{V},$ $V_{DS}=10\text{V},$ Frequency=1.0MHz	N-Ch	-	300	-
			P-Ch	-	375	-
C_{oss}	Output Capacitance	P-Channel $V_{GS}=0\text{V},$ $V_{DS}=-10\text{V},$ Frequency=1.0MHz	N-Ch	-	70	-
			P-Ch	-	70	-
C_{rss}	Reverse Transfer Capacitance	N-Channel $V_{GS}=0\text{V},$ $V_{DS}=-10\text{V},$ Frequency=1.0MHz	N-Ch	-	50	-
			P-Ch	-	50	-
$t_{d(ON)}$	Turn-on Delay Time	N-Channel $V_{DD}=10\text{V}, R_L=10\Omega,$ $I_{DS}=1\text{A}, V_{GEN}=4.5\text{V},$ $R_G=6\Omega$	N-Ch	-	4	8
			P-Ch	-	6	12
T_r	Turn-on Rise Time	N-Channel $V_{DD}=10\text{V}, R_L=10\Omega,$ $I_{DS}=1\text{A}, V_{GEN}=4.5\text{V},$ $R_G=6\Omega$	N-Ch	-	14	26
			P-Ch	-	14	26
$t_{d(OFF)}$	Turn-off Delay Time	P-Channel $V_{DD}=-10\text{V}, R_L=10\Omega,$ $I_{DS}=-1\text{A}, V_{GEN}=-4.5\text{V},$ $R_G=6\Omega$	N-Ch	-	21	39
			P-Ch	-	27	50
T_f	Turn-off Fall Time	N-Channel $V_{DD}=-10\text{V}, R_L=10\Omega,$ $I_{DS}=-1\text{A}, V_{GEN}=-4.5\text{V},$ $R_G=6\Omega$	N-Ch	-	5	10
			P-Ch	-	5	10
Gate Charge Characteristics^b						
Q_g	Total Gate Charge	N-Channel $V_{DS}=10\text{V}, V_{GS}=4.5\text{V},$ $I_{DS}=3\text{A}$	N-Ch	-	4.1	6
			P-Ch	-	4.2	6
Q_{gs}	Gate-Source Charge	P-Channel $V_{DS}=-10\text{V}, V_{GS}=-4.5\text{V},$ $I_{DS}=-2\text{A}$	N-Ch	-	0.4	-
			P-Ch	-	0.6	-
Q_{gd}	Gate-Drain Charge	N-Channel $V_{DS}=10\text{V}, V_{GS}=4.5\text{V},$ $I_{DS}=3\text{A}$	N-Ch	-	1.7	-
			P-Ch	-	1.3	-

Note a : Pulse test ; pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.

Note b : Guaranteed by design, not subject to production testing.

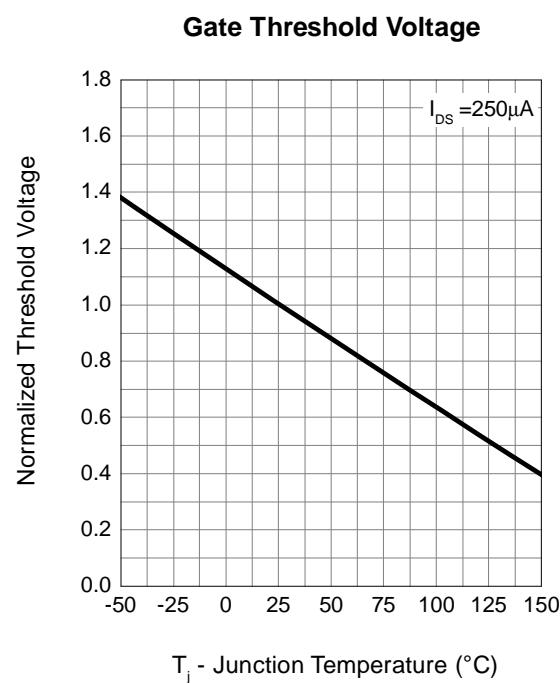
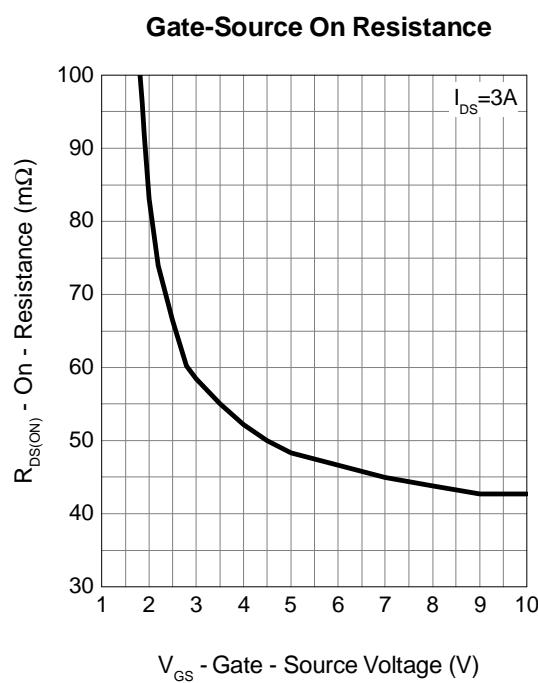
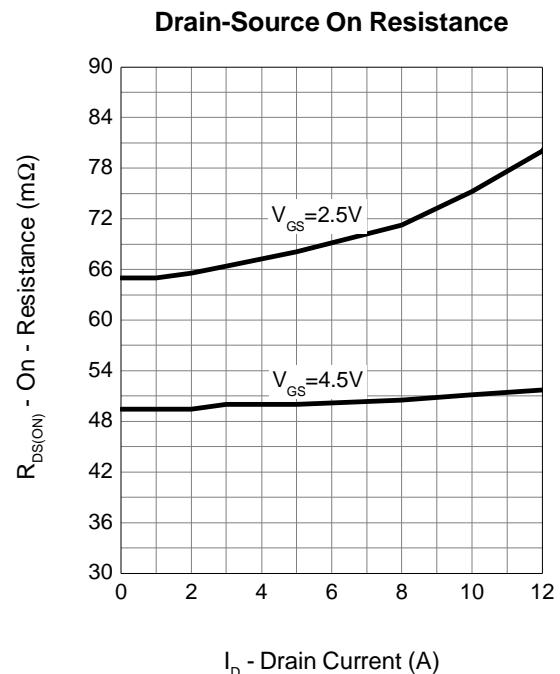
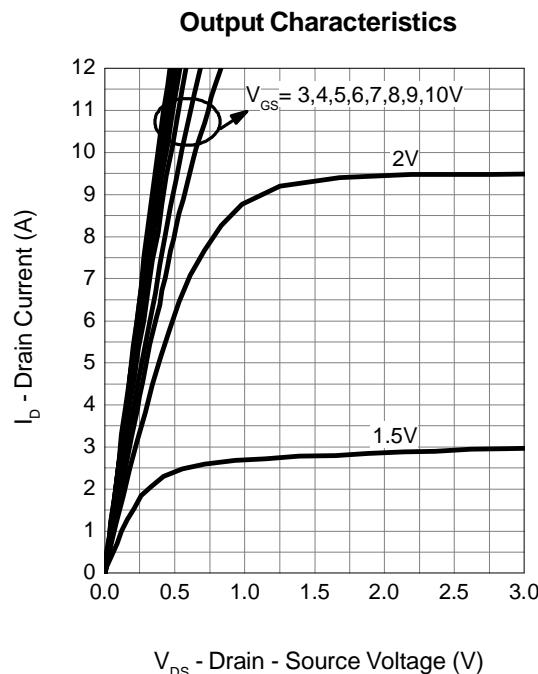
Typical Operating Characteristics

N-Channel



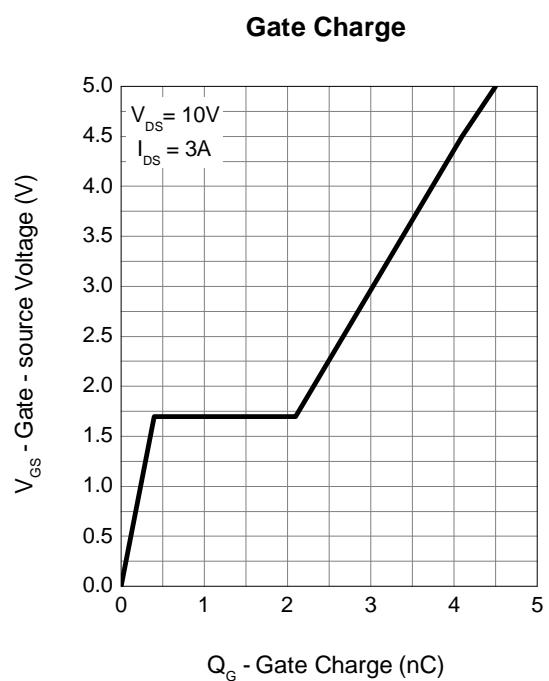
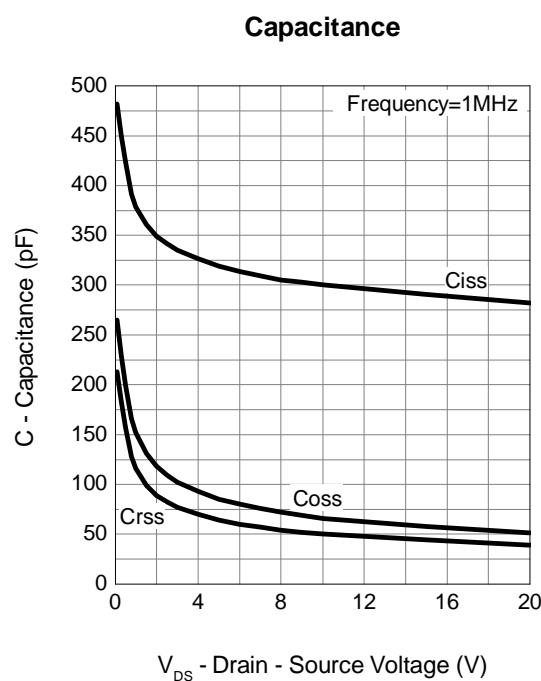
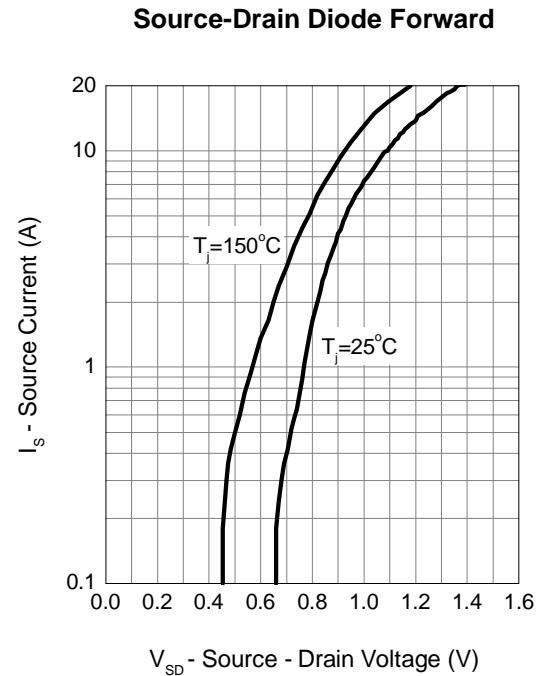
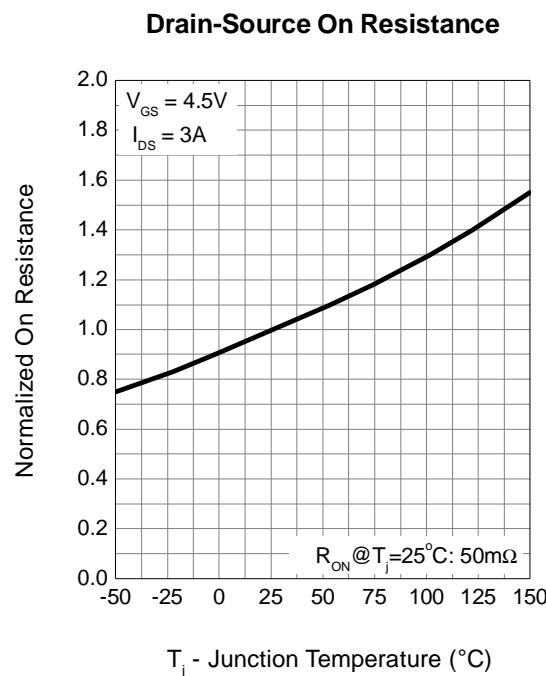
Typical Operating Characteristics (Cont.)

N-Channel



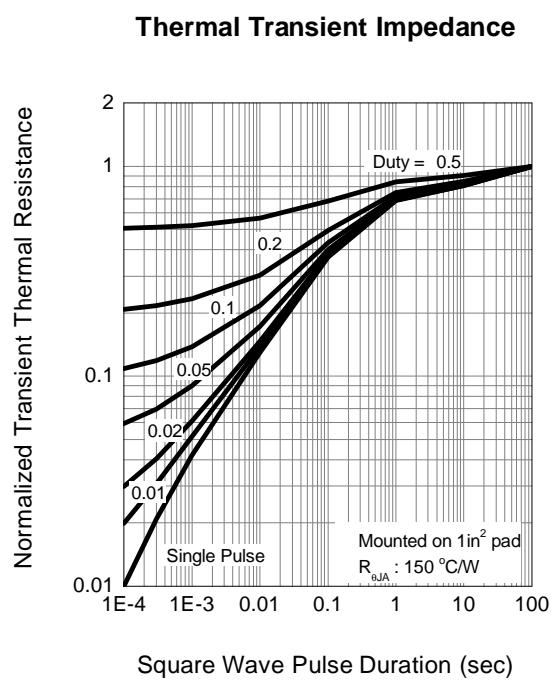
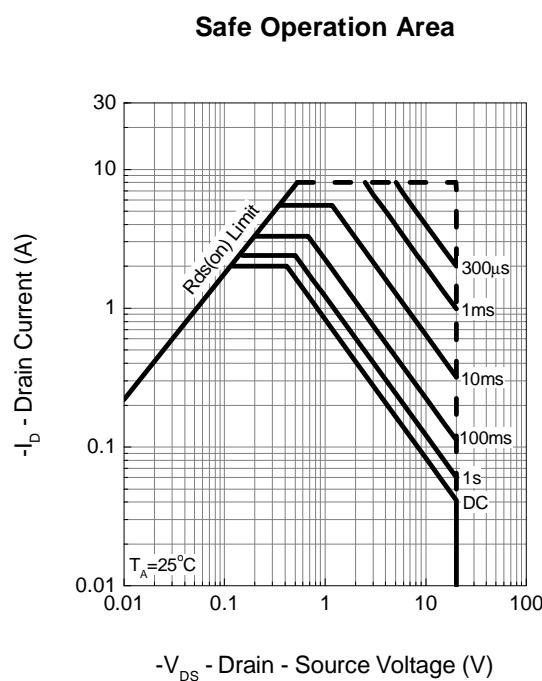
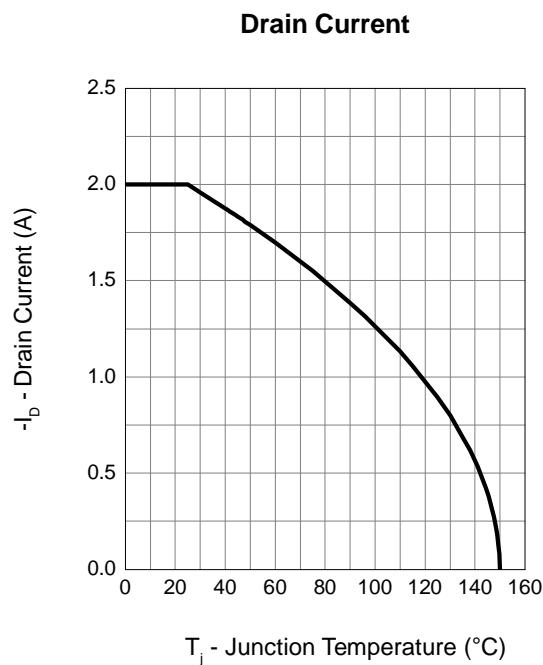
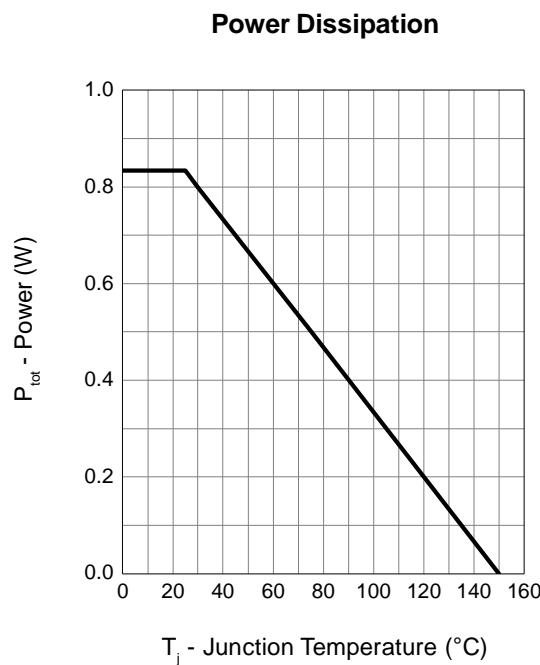
Typical Operating Characteristics (Cont.)

N-Channel



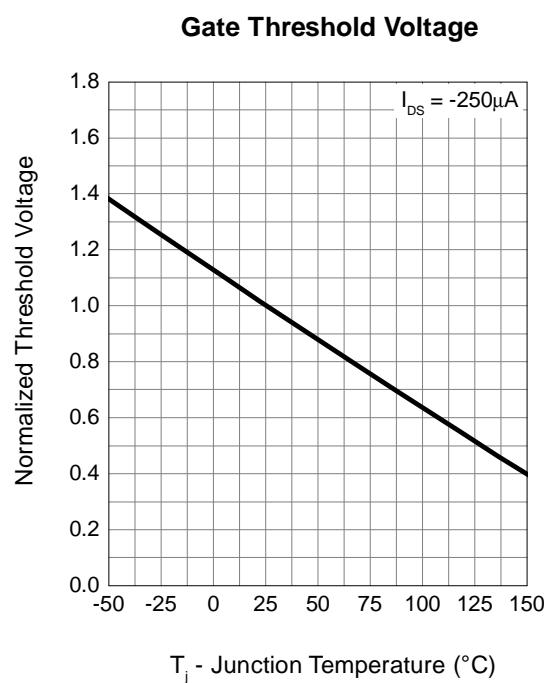
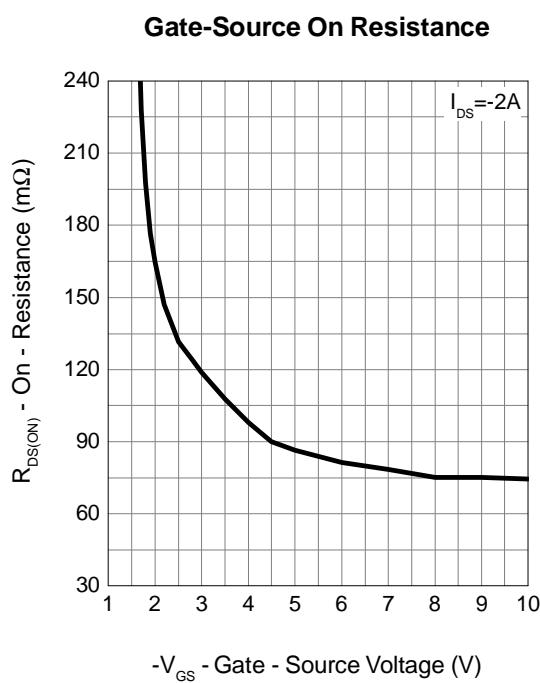
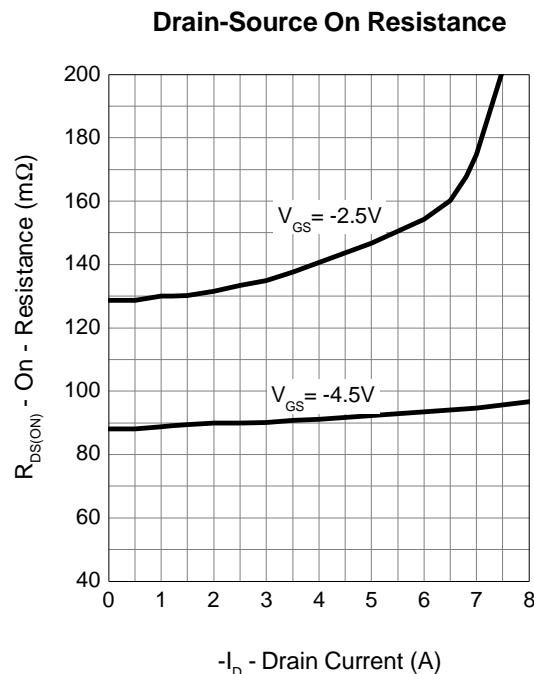
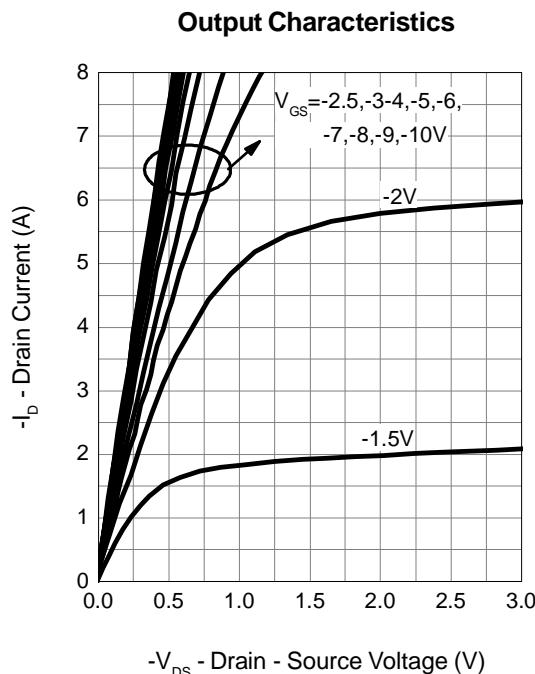
Typical Operating Characteristics (Cont.)

P-Channel



Typical Operating Characteristics (Cont.)

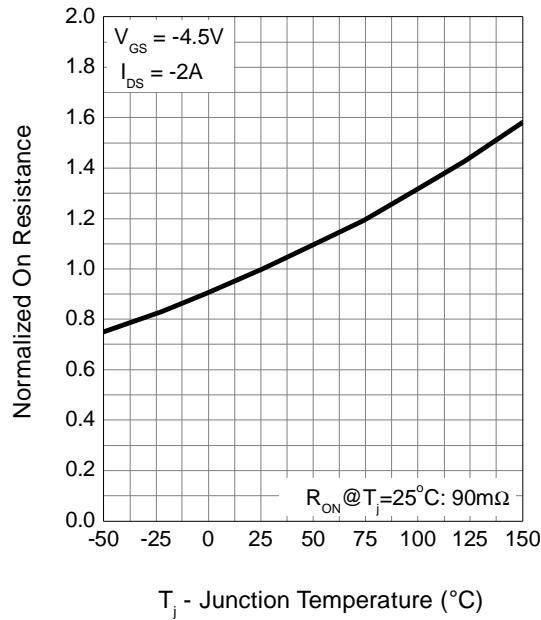
P-Channel



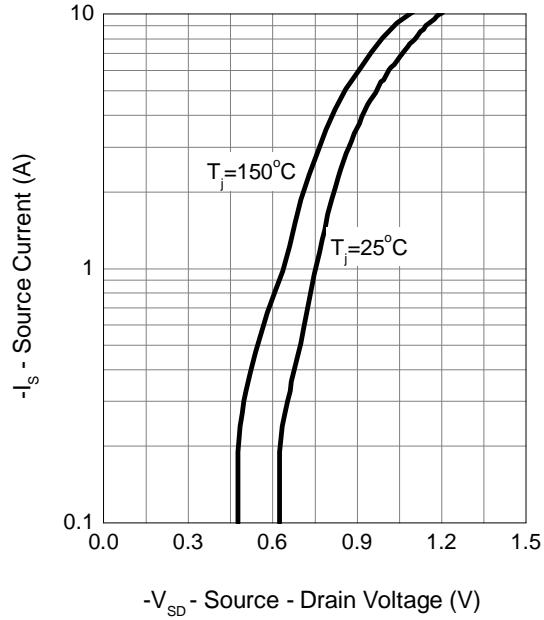
Typical Operating Characteristics (Cont.)

P-Channel

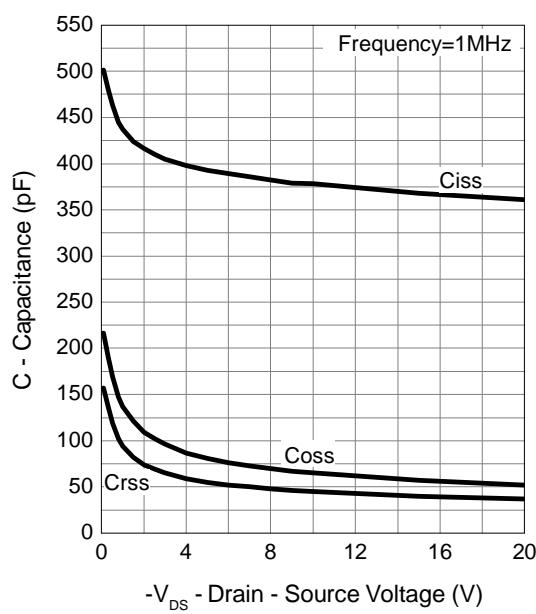
Drain-Source On Resistance



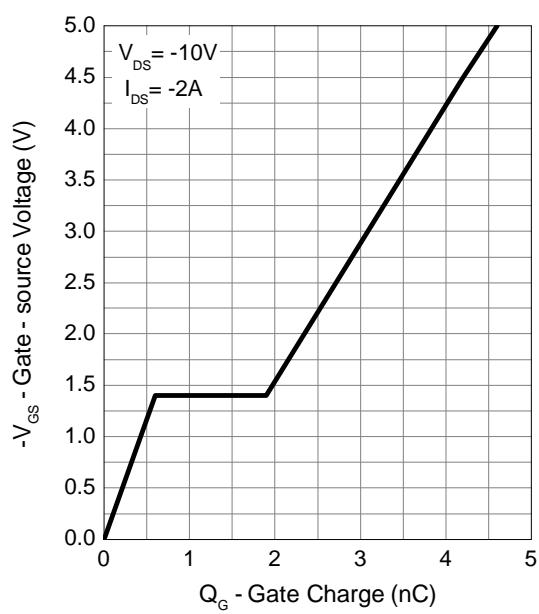
Source-Drain Diode Forward



Capacitance

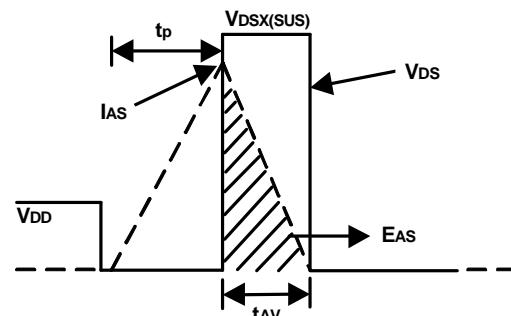
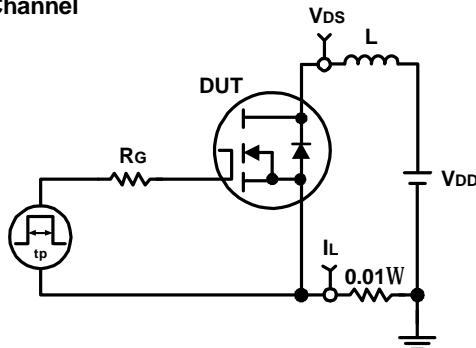


Gate Charge

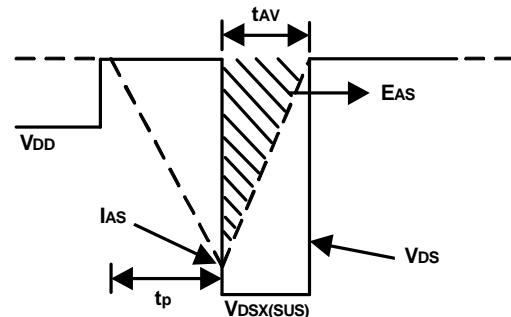
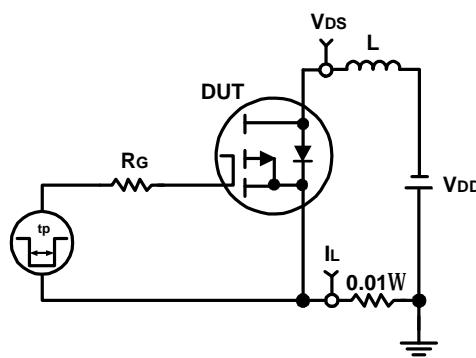


Avalanche Test Circuit and Waveforms

N Channel

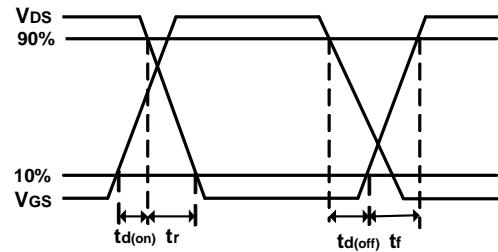
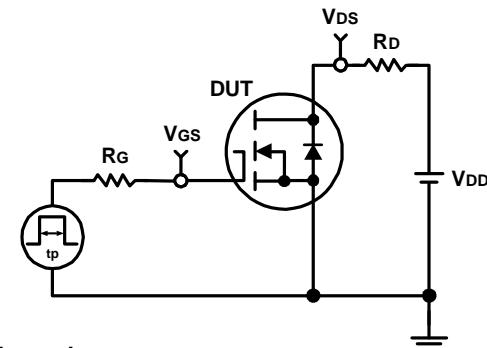


P Channel

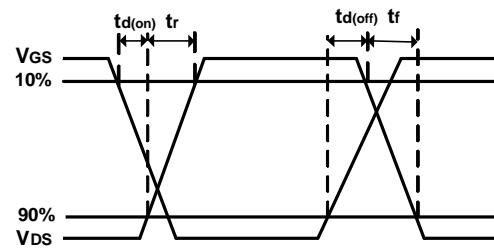
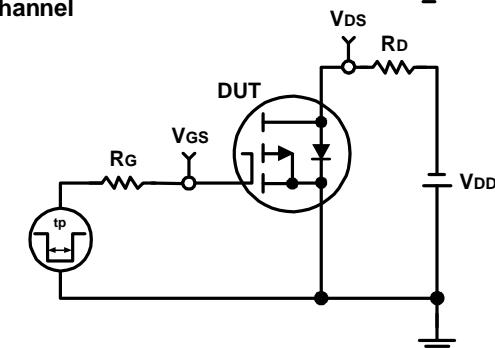


Switching Time Test Circuit and Waveforms

N Channel

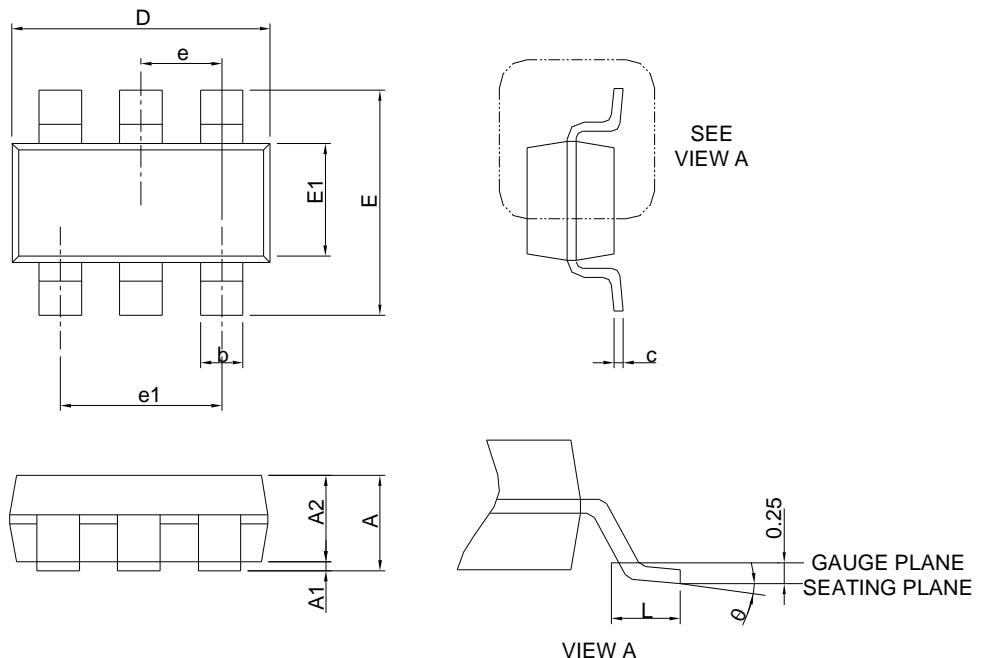


P Channel



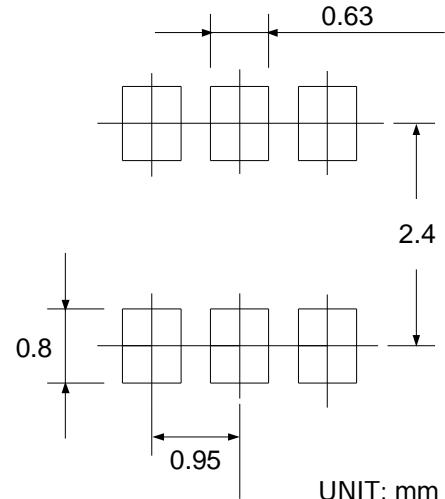
Package Information

SOT-23-6



SOT-23-6	SOT-23-6			
	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	-	1.25	-	0.049
A1	0.00	0.05	0.000	0.002
A2	0.90	1.20	0.035	0.047
b	0.30	0.50	0.012	0.020
c	0.08	0.22	0.003	0.009
D	2.70	3.10	0.106	0.122
E	2.60	3.00	0.102	0.118
E1	1.40	1.80	0.055	0.071
e	0.95 BSC		0.037 BSC	
e1	1.90 BSC		0.075 BSC	
L	0.30	0.60	0.012	0.024
θ	0°	8°	0°	8°

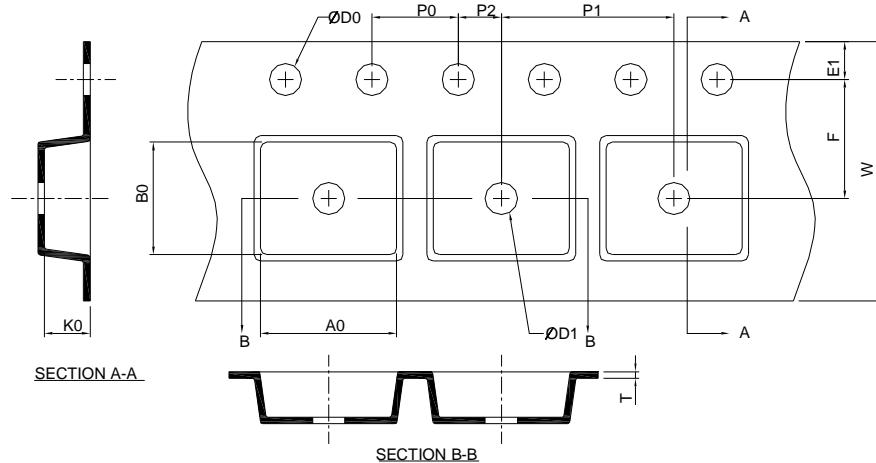
RECOMMENDED LAND PATTERN



Note : 1. Follow JEDEC TO-178 AB.

- 2. Dimension D and E1 do not include mold flash, protrusions or gate burrs. Mold flash, protrusion or gate burrs shall not exceed 10 mil per side.

Carrier Tape & Reel Dimensions

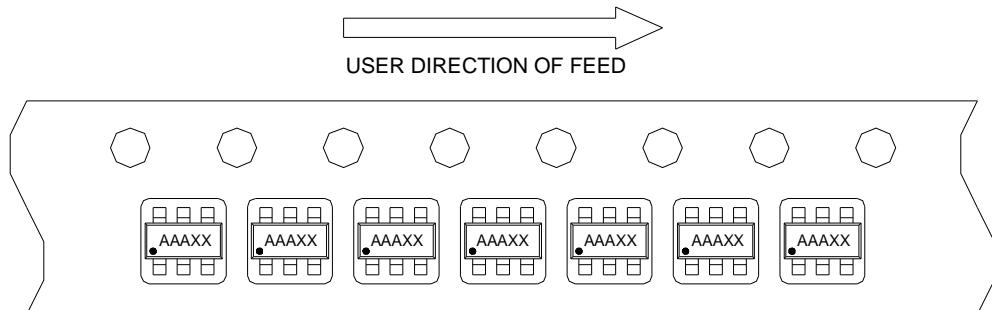


Application	A	H	T1	C	d	D	W	E1	F
SOT-23-6	178.0 ± 2.00	50 MIN.	$8.4 + 2.00$ -0.00	$13.0 + 0.50$ -0.20	1.5 MIN.	20.2 MIN.	8.0 ± 0.30	1.75 ± 0.10	3.5 ± 0.05
	P0	P1	P2	D0	D1	T	A0	B0	K0
	4.0 ± 0.10	4.0 ± 0.10	2.0 ± 0.05	$1.5 + 0.10$ -0.00	1.0 MIN.	$0.6 + 0.00$ -0.40	3.20 ± 0.20	3.10 ± 0.20	1.50 ± 0.20

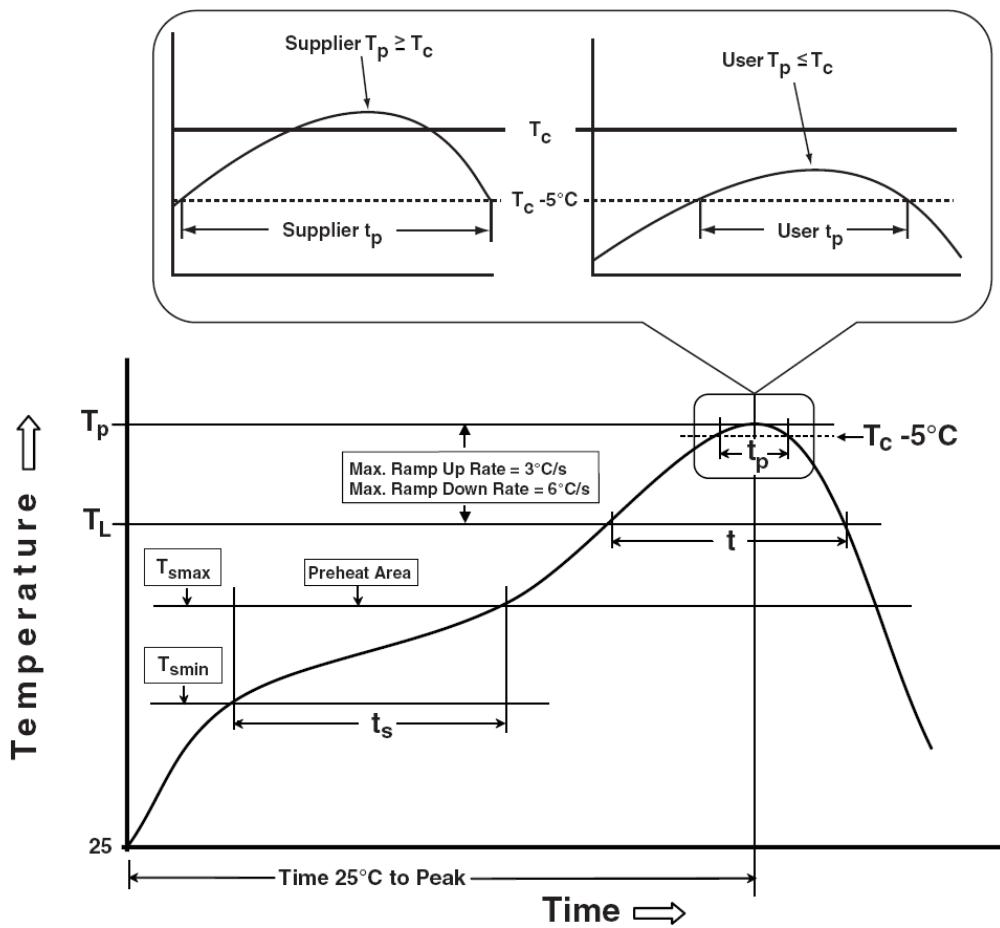
(mm)

Taping Direction Information

SOT-23-6



Classification Profile



Disclaimer

Sinopower Semiconductor, Inc. (hereinafter "Sinopower") has been making great efforts to development high quality and better performance products to satisfy all customers' needs. However, a product may fail to meet customer's expectation or malfunction for various situations.

All information which is shown in the datasheet is based on Sinopower's research and development result, therefore, Sinopower shall reserve the right to adjust the content and monitor the production.

In order to unify the quality and performance, Sinopower has been following JEDEC while defines assembly rule. Notwithstanding all the suppliers basically follow the rule for each product, different processes may cause slightly different results.

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Classification Reflow Profiles

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Preheat & Soak Temperature min (T_{smin}) Temperature max (T_{smax}) Time (T_{smin} to T_{smax}) (t_s)	100 °C 150 °C 60-120 seconds	150 °C 200 °C 60-120 seconds
Average ramp-up rate (T_{smax} to T_p)	3 °C/second max.	3°C/second max.
Liquidous temperature (T_L) Time at liquidous (t_L)	183 °C 60-150 seconds	217 °C 60-150 seconds
Peak package body Temperature (T_p)*	See Classification Temp in table 1	See Classification Temp in table 2
Time (t_p)** within 5°C of the specified classification temperature (T_c)	20** seconds	30** seconds
Average ramp-down rate (T_p to T_{smax})	6 °C/second max.	6 °C/second max.
Time 25°C to peak temperature	6 minutes max.	8 minutes max.

* Tolerance for peak profile Temperature (T_p) is defined as a supplier minimum and a user maximum.

** Tolerance for time at peak profile temperature (t_p) is defined as a supplier minimum and a user maximum.

Table 1. SnPb Eutectic Process – Classification Temperatures (T_c)

Package Thickness	Volume mm ³ <350	Volume mm ³ ≥350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2. Pb-free Process – Classification Temperatures (T_c)

Package Thickness	Volume mm ³ <350	Volume mm ³ 350-2000	Volume mm ³ >2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

Reliability Test Program

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HTRB	JESD-22, A108	1000 Hrs, 80% of VDS max @ Tjmax
HTGB	JESD-22, A108	1000 Hrs, 100% of VGS max @ Tjmax
PCT	JESD-22, A102	168 Hrs, 100%RH, 2atm, 121°C
TCT	JESD-22, A104	500 Cycles, -65°C~150°C

Customer Service

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